

Notice of References Cited	Application/Control No. 10/680,105		Applicant(s)/Patent Under Reexamination ABE ET AL.	
	Examiner STEVEN D. RADOSEVICH		Art Unit 2117	Page 1 of 1

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*	D	US-5,592,493	01-1997	Crouch et al.	714/729
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NON-PATENT DOCUMENTS

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	U	Sheldon B. Akers, Binary Decision Diagram, IEEE, June 1978, 509-516.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.